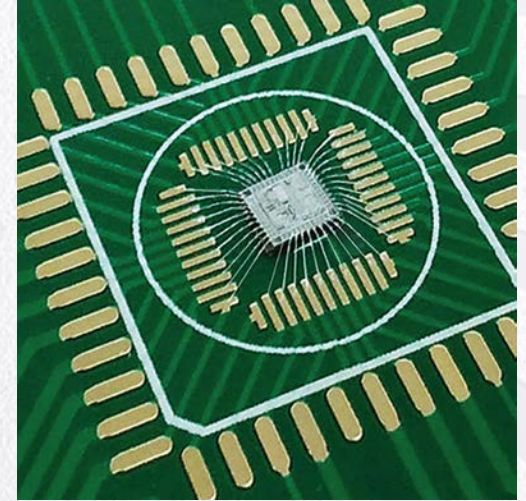
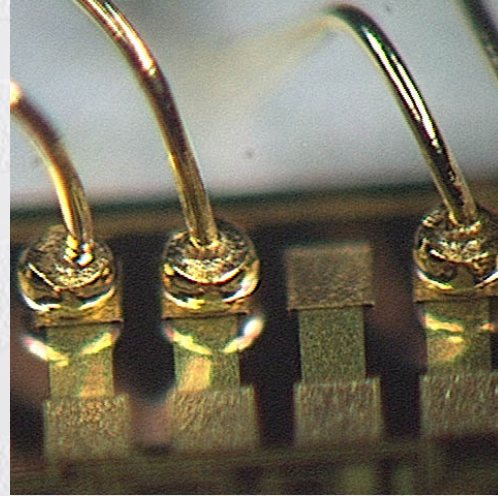
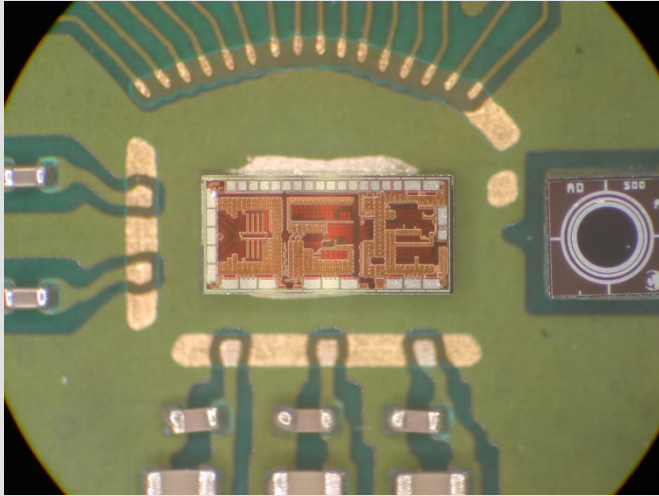


TechniPad ENEPIG

Wire Bond Data

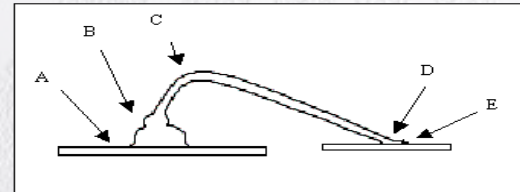


TechniPad 7611 Wire Bond Data

| | 27-69-8 | | 27-69-9 | |
|-------|-------------|------|-------------|------|
| | 5 m inch Pd | | 15 m inchPd | |
| Wire# | grams | code | grams | code |
| 1 | 7.1 | B | 8.1 | B |
| 2 | 7.6 | A | 7.7 | B |
| 3 | 4.5 | B | 6.1 | D |
| 4 | 6.6 | B | 4 | B |
| 5 | 6 | D | 6.8 | B |
| 6 | 3.9 | D | 3.7 | D |
| 7 | 8 | D | 6.2 | B |
| 8 | 7.2 | D | 4.4 | B |
| 9 | 5 | B | 3.6 | B |
| 10 | 4 | B | 8.5 | B |
| 11 | 3.9 | A | 4.8 | B |
| 12 | 4.6 | B | 5.5 | B |
| 13 | 6.1 | B | 4.8 | B |
| 14 | 6.1 | B | 6.6 | D |
| 15 | 7.9 | D | 4.3 | D |
| 16 | 7.5 | B | 6.1 | D |
| 17 | 8 | D | 5.2 | B |
| 18 | 5.7 | B | 5.5 | D |
| 19 | 4.5 | B | 8.6 | B |
| 20 | 6 | B | 5.3 | B |
| 21 | 3.9 | D | 5.2 | D |
| 22 | 8.5 | B | 4.4 | B |
| 23 | 5 | B | 6.2 | B |
| 24 | 9 | B | 5.6 | B |
| 25 | 6.8 | D | 3.5 | B |
| Ave | 6.136 | | 5.628 | |
| SD | 1.58977986 | | 1.48001126 | |

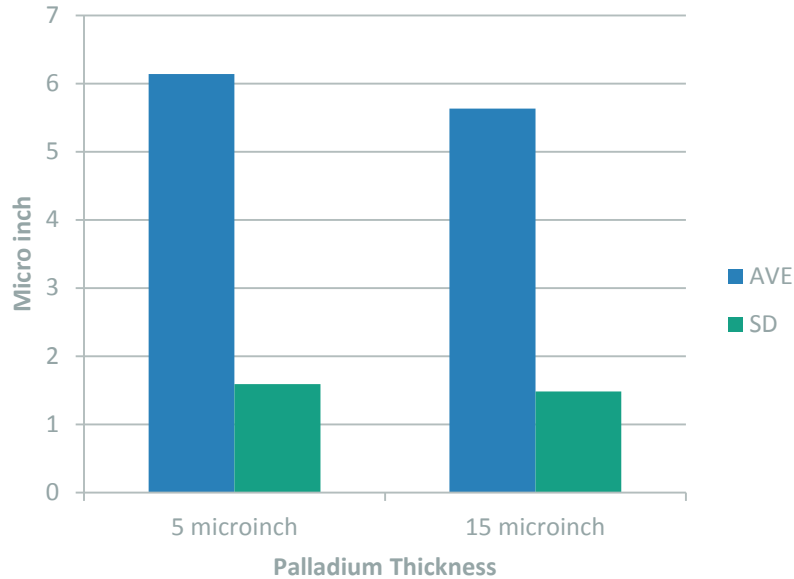
Test Parameters:

- Bonder: AB356 Automatic Gold Wire Ball Bonder
- Wire: 99.99% Gold , Size=30 μ ϕ , T.S.=10-15 gm
- Capillary: GAISER Tool Company (1572-17-437GM-20D)

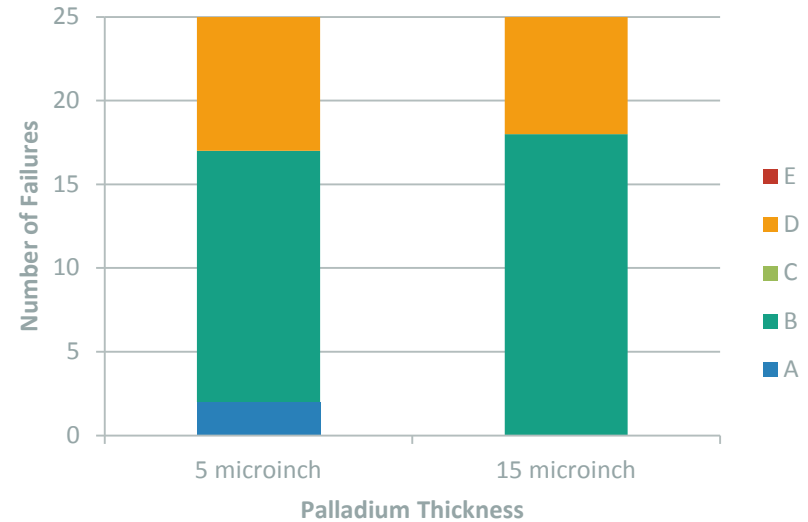


TechniPad 7611: Au Wire Bond Results

TechniPad 7611 Gold Wire Bond



TechniPad 7611 Wire Bond Failure Point



Wire Bond Testing TechniPad 7611 Thickness W & WO Aging

- Test Conditions
 - PCB plated with 0, 2, 10, & 20 micro inches of Pd from TechniPad 7611
 - As plated & after 4 hours @ 175 °C
- Wire Bonding Conditions
 - Iconn semi-automatic bonder
 - 1 mil gold wire
 - Capillary: GAISER Tool Company (1572-17-437GM-20D)
- Dage BT2400 Bond Tester



Raw Data Wire Bond TechniPad 7611 W & WO Aging

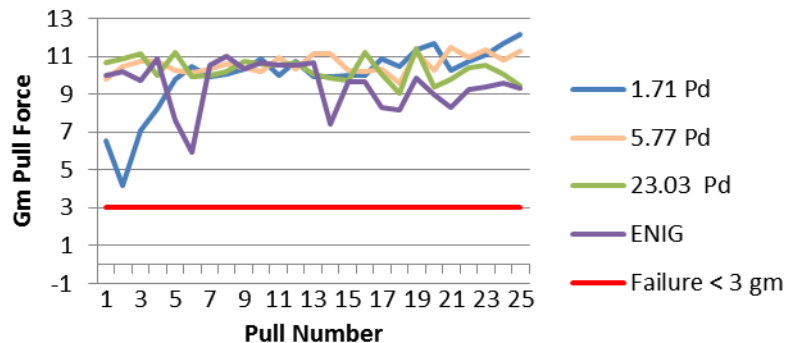
As Plated

- All pass biggest variation with ENIG & 2 micro inch Pd
- Little difference 5 & 20 m inch Pd

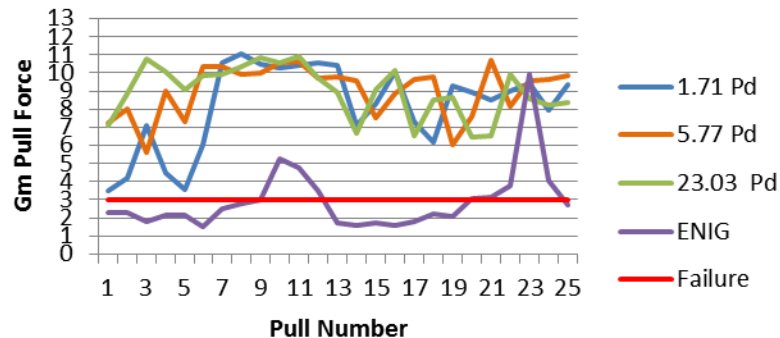
After 4 Hours 175 °C

- Complete ENIG failure & greater variation with 2 micro inch Pd
- Little difference 5 & 20 m inches Pd

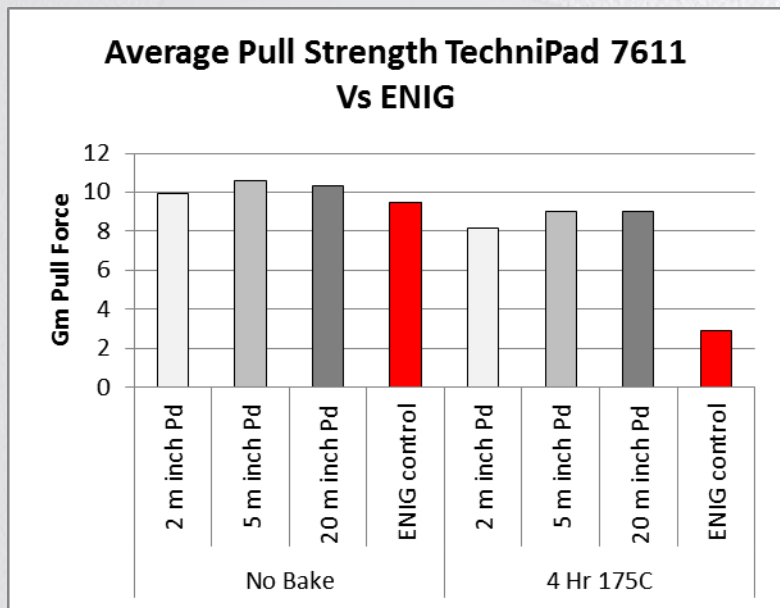
Wire Pull Data As Plated



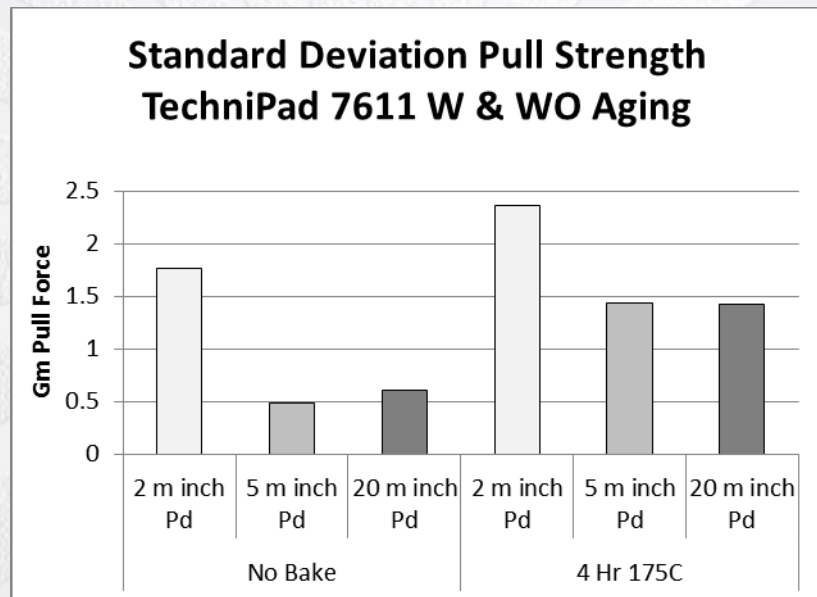
Wire Pull Data After 4Hour Bake 175C



Average & Std Dev TechniPad 7611 W & WO Aging



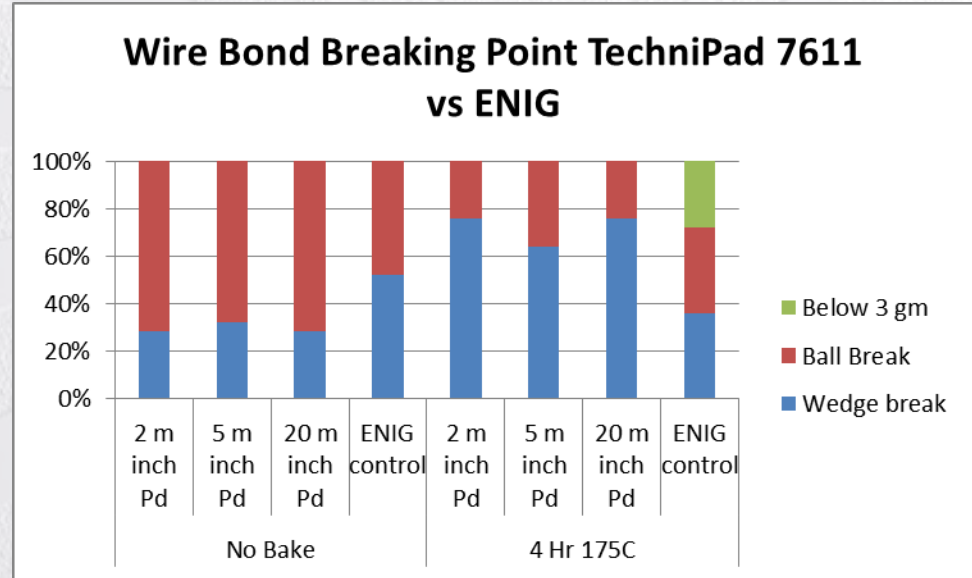
- As Plated all samples have similar results
- After bake Ave falls slightly & ENIG fails



- As plated SD high with 2 m inch Pd
- Similar SD with 5 & 20 W & WO bake

Wire Bond Results TechniPad 7611 W & WO Bake

- No failures of the bond to the ENEPIG were observed
- Even thin Pd improves protection of Ni substrate
- But thin Pd yields greater variation in bond strength
- For wire bonding applications 10 micro inch min suggested



THE SOLUTION: TechniPad ENIG & ENEPIG

- **Outstanding Assembly Performance**
 - Flat EN = No black pad/corrosion products on EN Surface
 - Proprietary immersion gold process with almost no Ni removal
 - Thin intermetallic
- **Lowest Operating Cost**
- **Solves ENIG Process Issues**
- **All Interconnect Applications**
 - Low contact & good wear resistance
 - Wire bondable
 - Solderable

